Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/661,204	LAIL ET AL.
Examiner	Art Unit
Hae M. Hyeon	2839

SEARCHED					
Class	Subclass	Date	Examiner		
		:			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Update Search Done	6/05	hmh	
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